

<b>Search Notes</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/066,024	BUER ET AL.
	Examiner	Art Unit
	Pablo N. Tran	2685

SEARCHED			
Class	Subclass	Date	Examiner
455	326	11/15/17	PL
	327		
	323-325		
	319		
	333		
	315-316		
	209		
	313		
	314		
	426		
	188.1		
	189.1		
	190.1		
	582-583		

**Search Notes (continued)**

Application/Control No.

10/066,024

Examiner

Pablo N. Tran

Applicant(s)/Patent under  
Reexamination

BUER ET AL.

Art Unit

2685

**SEARCHED**

Class	Subclass	Date	Examiner
455	353	11/05/05	PL
333	1.1		
	24.2		
	245-247		
	248		
	260		
331	96		
	108C		
	117D		
	117FE		
	172		
	177R		
343	700MS		
	701-705		
	841		
	883		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR